

ecoSwitch[™]

Advanced Load Management

Controlled Load Switch with

Reverse Current Protection and

Low R_{ON}

NCP45780

The NCP45780 load management device provides a component and area-reducing solution for efficient power domain switching with inrush current limit via soft start. These devices are designed to integrate control and driver functionality with back-to-back high performance low on-resistance power MOSFETs in a single package. This cost effective solution is ideal for reverse current applications and the specific power management and disconnect functions used in USB Type-C and Type-C Power Delivery ports.

Features

- Advanced Controller with Charge Pump
- Integrated N-Channel MOSFET with Low R_{ON}
- Soft-Start via Controlled Slew Rate
- Adjustable Slew Rate Control
- Fault Detection with Power Good Output
- Thermal Shutdown and Under Voltage Lockout
- Short-Circuit and Adjustable Over-Current Protections
- Reverse-current Protection
- Input Voltage Range 3 V to 24 V
- Extremely Low Standby Current
- This is a Pb-free Device

Typical Applications

- USB Type C Power Delivery
- Reverse Current Load Switching Applications
- Notebook and Tablet Computers
- Telecom, Networking, Medical and Industrial Equipment
- Set-Top Boxes, Servers and Gateways
- Hot-Swap Devices and Peripheral Ports

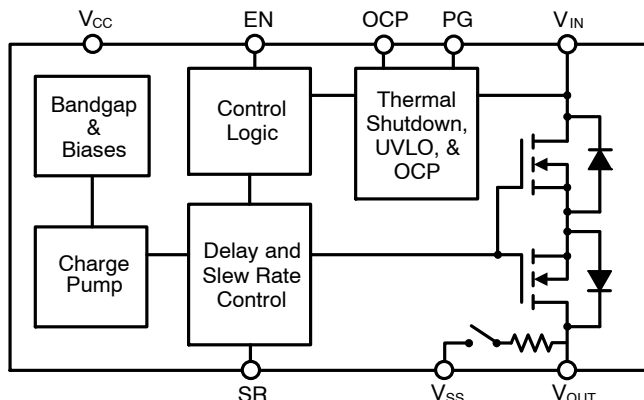


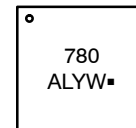
Figure 1. Block Diagram

R_{ON} TYP	V_{CC}	V_{IN}	I_{MAX}
13.5 mΩ	4.5 V	3 V	7 A



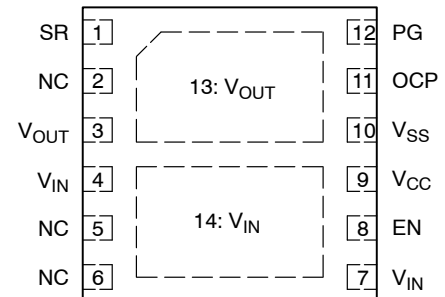
DFN12, 3x3
CASE 506EN

MARKING DIAGRAM



780 = Specific Device Code
A = Assembly Location
L = Wafer Lot
YW = Year / Week
▪ = Pb-Free Package

PIN CONFIGURATION



(Top View)

ORDERING INFORMATION

Device	Package	Shipping [†]
NCP45780IMN24RTWG	DFN12	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NCP45780

Table 1. PIN DESCRIPTION

Pin	Name	Function
1	SR	Slew Rate control pin. Slew rate adjustment made with an external capacitor to GND; float if not used.
3,13	V _{OUT}	Source of MOSFET connected to load.
4,7,14	V _{IN}	Input voltage (3 V – 24 V)
8	EN	Active–high digital input used to turn on the MOSFET driver, pin has an internal pull down resistor to GND.
9	V _{CC}	Driver supply voltage (3.0 V – 5.5 V)
10	V _{SS}	Driver ground
11	OCP	Over–current protection trip point adjustment made with a voltage applied (0 V – 1.2 V), pin has an internal pull up resistor to EN; short to ground if over–current protection is not needed.
12	PG	Active–high, open–drain output that indicates when the gate of the MOSFET is fully charged, external pull up resistor $\geq 100\text{ k}\Omega$ to an external voltage source required; tie to GND if not used.

Table 2. ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Supply Voltage Range	V _{CC}	–0.3 to 6	V
Input Voltage Range	V _{IN}	–0.3 to 30	V
Output Voltage Range	V _{OUT}	–0.3 to 30	V
EN Input Voltage Range	V _{EN}	–0.3 to (V _{CC} + 0.3)	V
PG Output Voltage Range (Note 1)	V _{PG}	–0.3 to 6	V
OCP Input Voltage Range	V _{OCP}	–0.3 to 6	V
Thermal Resistance, Junction–to–Ambient, Steady State (Note 2)	R _{θJA}	176.16	°C/W
Thermal Resistance, Junction–to–Case (V _{IN} Paddle)	R _{θJC}	2.5	°C/W
Continuous MOSFET Current @ T _A = 25°C (Note 2)	I _{MAX}	20	A
Total Power Dissipation @ T _A = 25°C (Note 2) Derate above T _A = 25°C	P _D	3.49 34.9	W mW/°C
Storage Temperature Range	T _{STG}	–55 to 150	°C
Lead Temperature, Soldering (10 sec.)	T _{SLD}	260	°C
ESD Capability, Human Body Model (Notes 3, 4)	ESD _{HBM}	2	kV
ESD Capability, Charged Device Model (Notes 3, 4)	ESD _{CDM}	1	kV
Latch–up Current Immunity (Note 3)	LU	100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. PG is an open drain output that requires an external pull–up resistor $> 100\text{ k}\Omega$ to an external voltage source.
2. Surface–mounted on FR4 board using the minimum recommended pad size, 1 oz Cu. Over current protection will limit maximum realized current to 12.5 A at highest setting.
3. Tested by the following methods @ T_A = 25°C:
 ESD Human Body Model tested per JESD22–A114
 ESD Charged Device Model per ESD STM5.3.1
 Latch–up Current tested per JESD78
4. Rating is for all pins except for V_{IN} and V_{OUT} which are tied to the internal MOSFET's Drain and Source. Typical MOSFET ESD performance for V_{IN} and V_{OUT} should be expected and these devices should be treated as ESD sensitive.

Table 3. OPERATING RANGES

Rating	Symbol	Min	Max	Unit
$V_{CC} - (V_{IN} > 4.5 \text{ V})$	V_{CC}	3	5.5	V
$V_{CC} - (V_{IN} < 4.5 \text{ V})$	V_{CC}	4.5	5.5	V
$V_{IN} - (V_{CC} > 4.5 \text{ V})$	V_{IN}	3	24	V
$V_{IN} - (V_{CC} < 4.5 \text{ V})$	V_{IN}	4.5	24	V
OFF to ON Transition Energy Dissipation Limit (See application section)	E_{TRANS}	0	100	mJ
OCP External Resistor to VSS	R_{OCP}	short	open	k Ω
VSS	V_{SS}		0	V
Ambient Temperature	T_A	-40	85	°C
Junction Temperature	T_J	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 4. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, $V_{CC} = 3 \text{ V} - 5.5 \text{ V}$, unless otherwise specified)

Parameter	Conditions	Symbol	Min	Typ	Max	Unit
On-Resistance	$V_{CC} = 4.5 \text{ V}$, $V_{IN} = 3 \text{ V}$	R_{ON}		13.5	16	m Ω
Leakage Current - V_{IN} to V_{OUT} (Note 5)	$V_{EN} = 0 \text{ V}$, $V_{IN} = 24 \text{ V}$, $V_{CC} = 5.5 \text{ V}$	I_{LEAK}		35	100	nA
Leakage Current - V_{OUT} to V_{IN} (Notes 5, 6)	$V_{EN} = 0 \text{ V}$, $V_{IN} = 24 \text{ V}$, $V_{CC} = 5.5 \text{ V}$	I_{LEAK}		35	100	nA
V_{IN} Control Current - V_{IN} to V_{SS}	$V_{EN} = 0 \text{ V}$, $V_{IN} = 24 \text{ V}$, $V_{CC} = 5.5 \text{ V}$	I_{INCTL}		0.8	1.5	μA
	$V_{EN} = V_{CC}$, $V_{IN} = 24 \text{ V}$, $V_{CC} = 5.5 \text{ V}$	I_{INCTL_EN}		150	300	μA
Supply Standby Current (Note 7)	$V_{EN} = 0 \text{ V}$, $V_{CC} = 5.5 \text{ V}$	I_{STBY}		1.6	5	μA
Supply Dynamic Current (Notes 8, 14)	$V_{EN} = V_{CC}$, $V_{CC} = 5.5 \text{ V}$	I_{DYN}		350	500	μA
EN Input High Voltage (Note 14)		V_{IH}	2			V
EN Input Low Voltage		V_{IL}			0.8	V
EN Input Leakage Current	$V_{EN} = 0 \text{ V}$	I_{IL}	-1.0	0.06	1	μA
EN Pull Down Resistance		R_{PD}	76	100	124	k Ω
PG Output Low Voltage	$I_{SINK} = 100 \mu\text{A}$	V_{OL}		20	100	mV
PG Output Leakage Current	$V_{TERM} = 3.3 \text{ V}$	I_{OH}		5	100	nA
Slew Rate Control Constant (Notes 9, 11)		K_{SR}	70	110	130	μA

FAULT PROTECTIONS

Thermal Shutdown Threshold (Note 10)		T_{SDT}		145		°C
Thermal Shutdown Hysteresis (Note 10)		T_{HYS}		20		°C
V_{IN} Under Voltage Lockout Threshold	V_{IN} rising	V_{UVLO}		2		V
V_{IN} Under Voltage Lockout Hysteresis		V_{HYS}		200		mV
Over-Current Protection Trip	$R_{OCP} = \text{open}$	I_{TRIP}	0.5	0.75	1.3	A
	$R_{OCP} = 100 \text{ k}\Omega$			3.1		
	$R_{OCP} = 20 \text{ k}\Omega$			5.7		
	$R_{OCP} = \text{short to GND}$			7.7		
Over-Current Protection Blanking Time		t_{OCP}		2.25		ms
Short-Circuit Protection Trip Current	(Notes 12, 13)	I_{SC}		12.5		A

5. Average current from V_{IN} to V_{OUT} with MOSFET turned off.

6. Reverse current protection prevents current flow from V_{OUT} to V_{IN} when the EN pin is low. When EN is asserted, current is allowed to travel in either direction.

7. Average current from V_{CC} to GND with MOSFET turned off.

8. Average current from V_{CC} to GND after charge up time of MOSFET.

9. See Applications Information section for details on how to adjust the gate slew rate.

10. Operation above $T_J = 125^\circ\text{C}$ is not implied.

11. Loads with changing impedance may cause inconsistent slew rate.

12. Transient currents exceeding the short-circuit protection trip current will cause the device to fault. For OCP setting less than 20 k Ω , high steady state currents may cause an over temperature lockout before the OCP threshold is reached due to self-heating.

13. Short Circuit Protection protects the device against hard shorts ($R_{SHORT} \leq 250 \text{ m}\Omega$ V_{OUT} to Ground) for $V_{IN} < 18 \text{ V}$, and against soft shorts ($R_{SHORT} > 250 \text{ m}\Omega$) for $V_{IN} < 24 \text{ V}$. Short circuit protection testing assumed a 100 W supply capability limit on V_{IN} .

14. The voltage on EN be $< 0.8 \text{ V}$ or within $\pm 0.7 \text{ V}$ of V_{CC} to prevent leakage from V_{CC} to EN exceeding the specified maximum dynamic current. Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NCP45780

Table 5. SWITCHING CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified) (Notes 15, 16)

Parameter	Conditions	Symbol	Min	Typ	Max	Unit
Output Slew Rate – Default (Note 17)	$V_{CC} = 4.5\text{ V}; V_{IN} = 3\text{ V}$	SR	13	20.5	29	V/ms
	$V_{CC} = 5.0\text{ V}; V_{IN} = 3\text{ V}$		13	20.5	29	
	$V_{CC} = 3.3\text{ V}; V_{IN} = 24\text{ V}$		13	22.5	29	
	$V_{CC} = 5.0\text{ V}; V_{IN} = 24\text{ V}$		13	22.5	29	
Output Turn-on Delay	$V_{CC} = 4.5\text{ V}; V_{IN} = 3\text{ V}$	T_{ON}	100	175	700	μs
	$V_{CC} = 5.0\text{ V}; V_{IN} = 3\text{ V}$		100	175	700	
	$V_{CC} = 3.3\text{ V}; V_{IN} = 24\text{ V}$		100	475	700	
	$V_{CC} = 5.0\text{ V}; V_{IN} = 24\text{ V}$		100	475	700	
Output Turn-off Delay	$V_{CC} = 3.0\text{ V}; V_{IN} = 3\text{ V}$	T_{OFF}		83		μs
	$V_{CC} = 5.5\text{ V}; V_{IN} = 3\text{ V}$			56		
	$V_{CC} = 3.0\text{ V}; V_{IN} = 24\text{ V}$			50		
	$V_{CC} = 5.5\text{ V}; V_{IN} = 24\text{ V}$			42		
Power Good Turn-on Time	$V_{CC} = 4.5\text{ V}; V_{IN} = 3\text{ V}$	$T_{PG,ON}$	0.25	0.575	4.0	ms
	$V_{CC} = 5.0\text{ V}; V_{IN} = 3\text{ V}$		0.25	0.535	4.0	
	$V_{CC} = 3.3\text{ V}; V_{IN} = 24\text{ V}$		0.25	1.8	4.0	
	$V_{CC} = 5.0\text{ V}; V_{IN} = 24\text{ V}$		0.25	1.6	4.0	
Power Good Turn-off Time	$V_{CC} = 4.5\text{ V}; V_{IN} = 3\text{ V}$	$T_{PG,OFF}$		10		ns
	$V_{CC} = 5.0\text{ V}; V_{IN} = 3\text{ V}$			10		
	$V_{CC} = 3.3\text{ V}; V_{IN} = 24\text{ V}$			10		
	$V_{CC} = 5.0\text{ V}; V_{IN} = 24\text{ V}$			10		

15. See below figure for Test Circuit and Timing Diagram.

16. Tested with the following conditions: $V_{TERM} = V_{CC}$; $R_{PG} = 100\text{ k}\Omega$; $R_L = 10\text{ }\Omega$; $C_L = 0.1\text{ }\mu\text{F}$.

17. Loads with changing impedance may cause inconsistent slew rate.

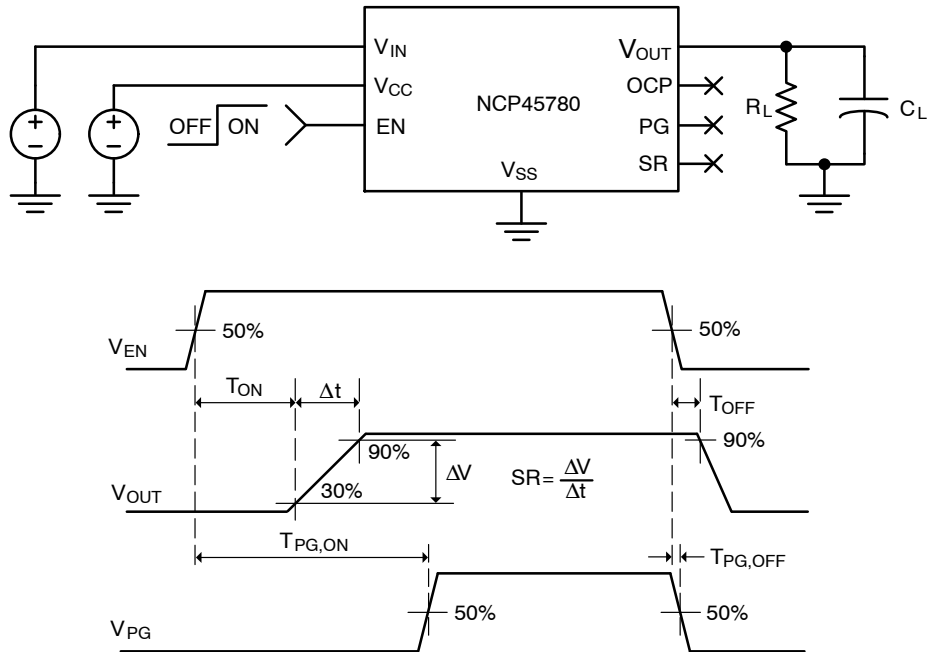


Figure 2. Switching Characteristics Test Circuit and Timing Diagrams

TYPICAL CHARACTERISTICS

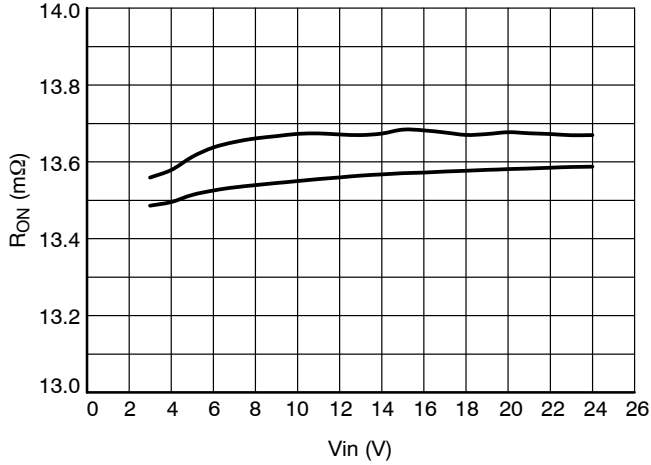


Figure 3. On-Resistance vs. Input Voltage

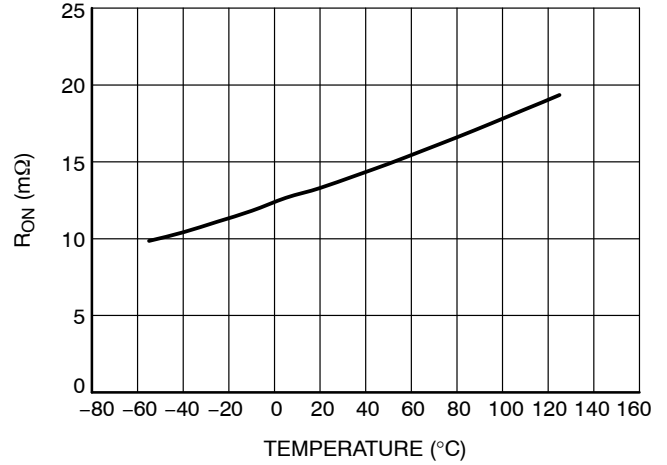


Figure 4. On-Resistance vs. Temperature

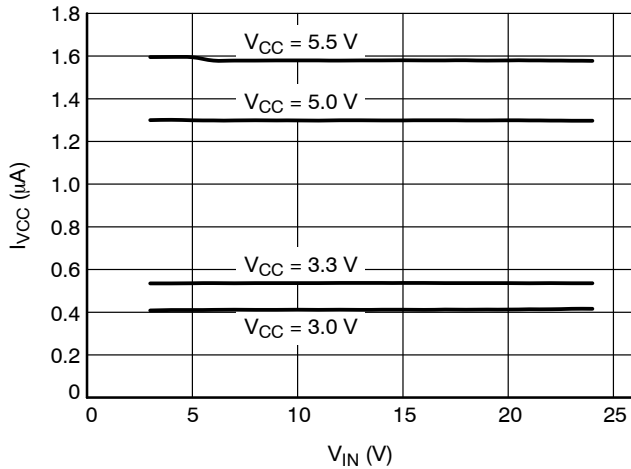


Figure 5. Supply Standby Current vs. Input Voltage

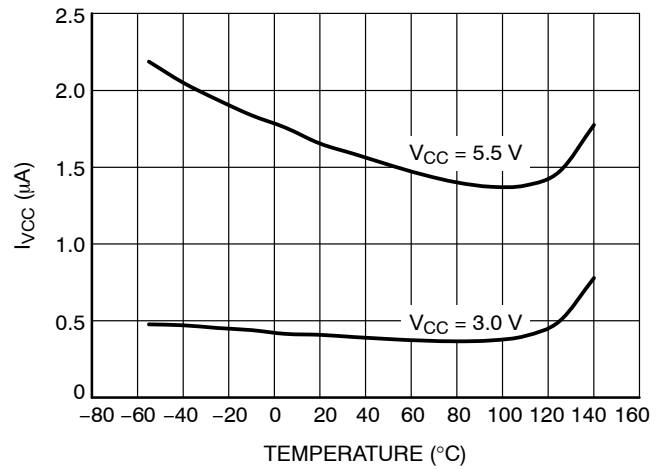


Figure 6. Supply Standby Current vs. Temperature

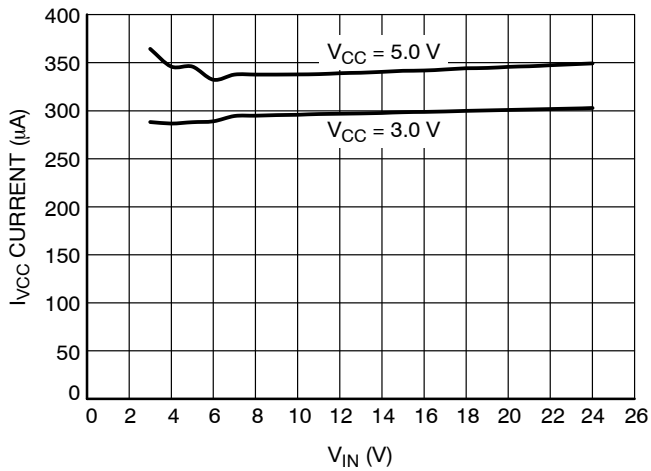


Figure 7. Dynamic Current vs. Input Voltage

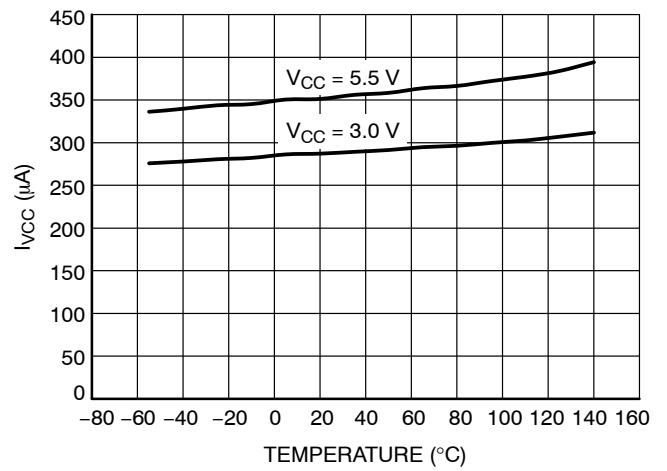


Figure 8. Supply Dynamic Current vs. Temperature

TYPICAL CHARACTERISTICS

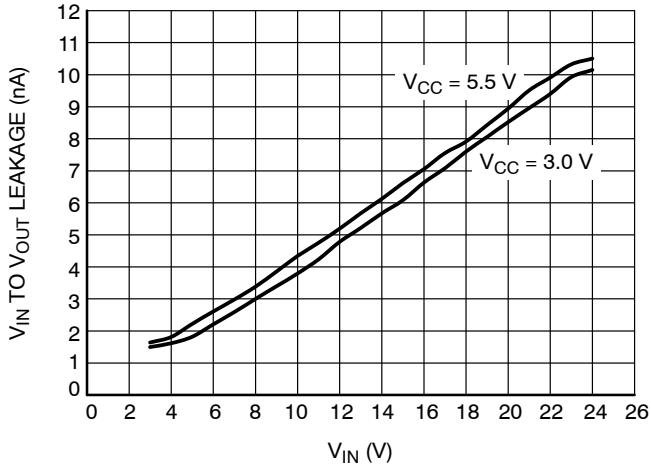


Figure 9. V_{IN} to V_{OUT} Leakage with $EN = 0$ V

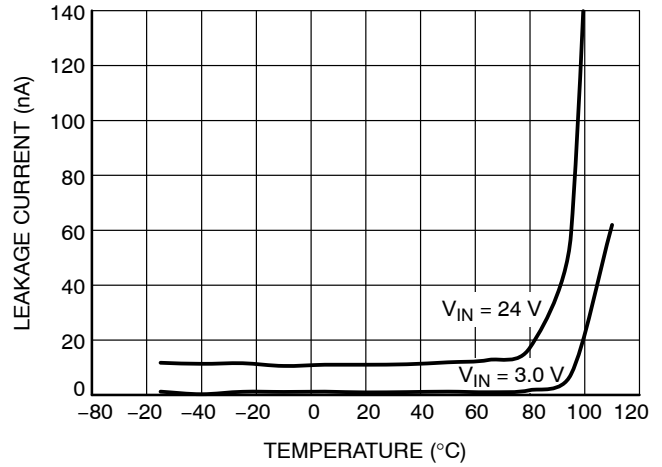


Figure 10. Input to Output Leakage vs. Temperature

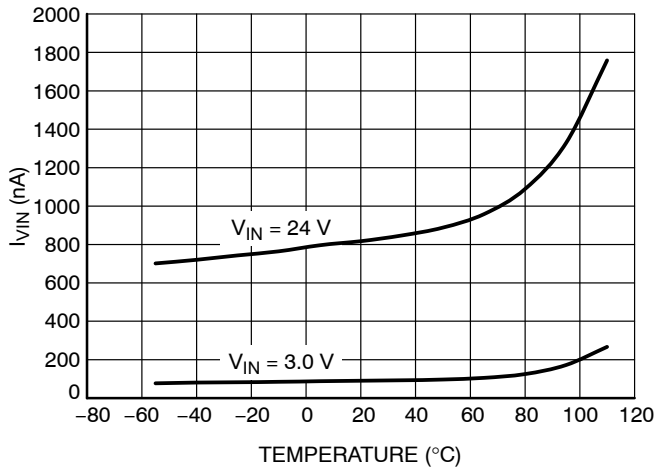


Figure 11. V_{IN} Controller Current vs. Temperature ($EN = 0$)

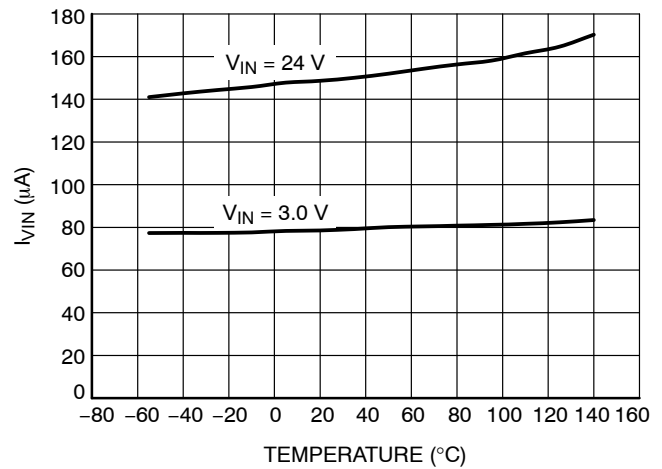


Figure 12. V_{IN} Controller Current vs. Temperature ($EN = V_{CC}$)

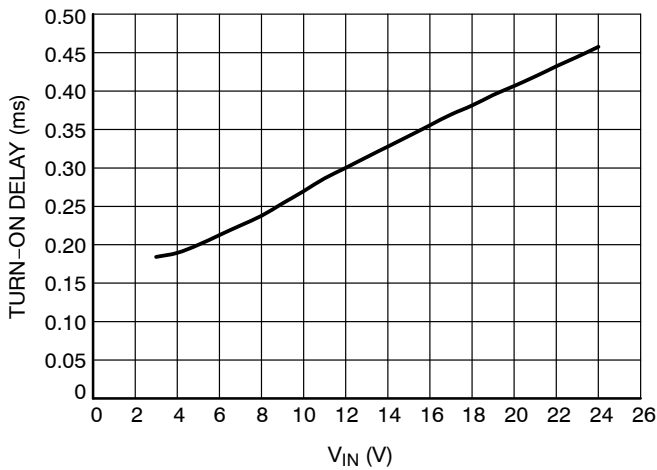


Figure 13. Output Turn-On Delay vs. Input Voltage

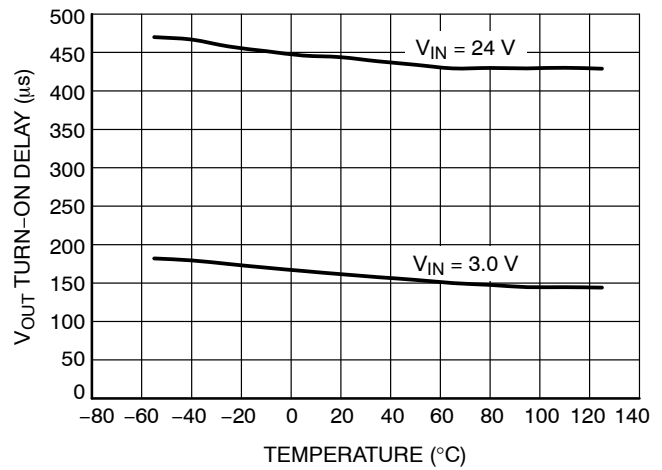


Figure 14. Output Turn-On Delay vs. Temperature

TYPICAL CHARACTERISTICS

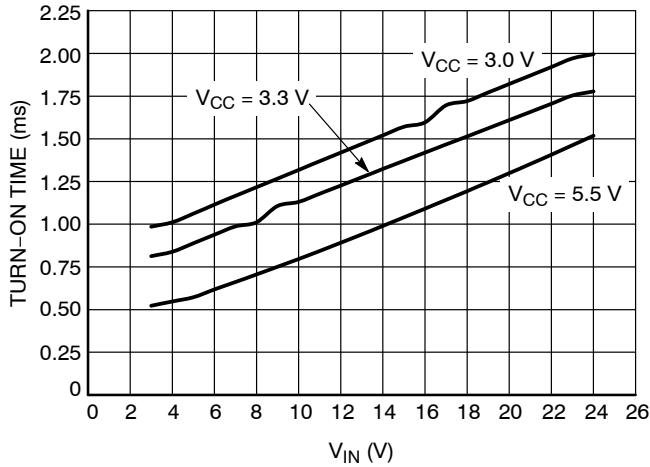


Figure 15. Power Good Turn-On Time vs. Input Voltage

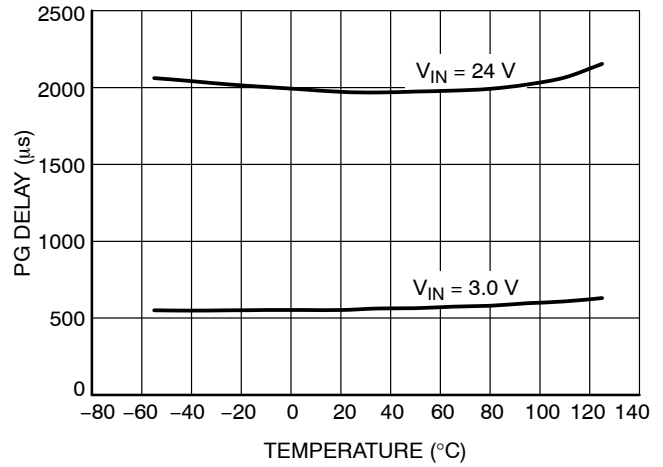


Figure 16. Power Good Turn-On Delay vs. Temperature

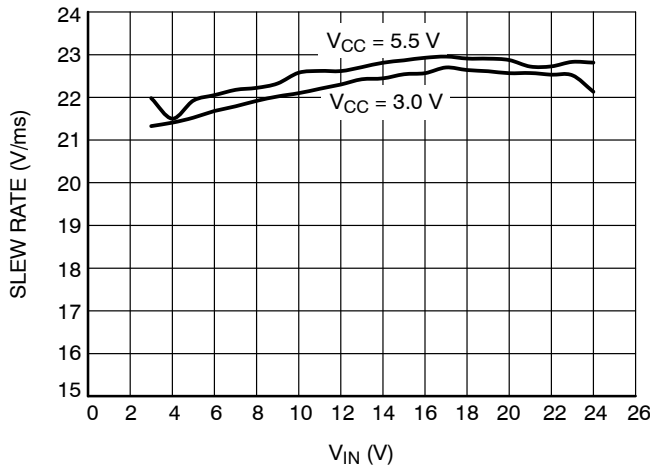


Figure 17. Default Slew Rate vs. Input Voltage (SR pin = floating)

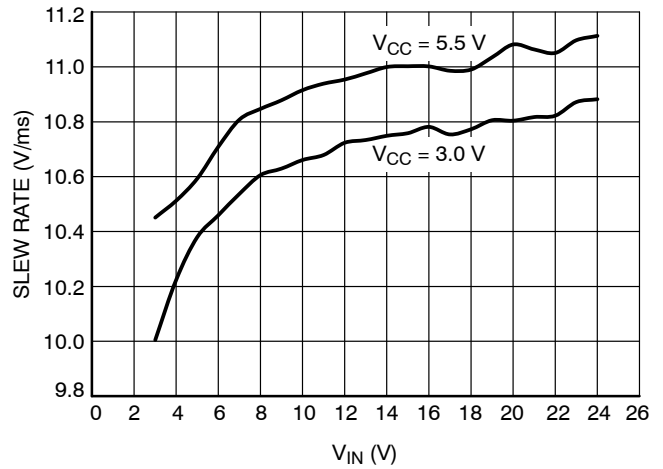


Figure 18. Slew Rate vs. Input Voltage (SR pin = 10 nF to GND)

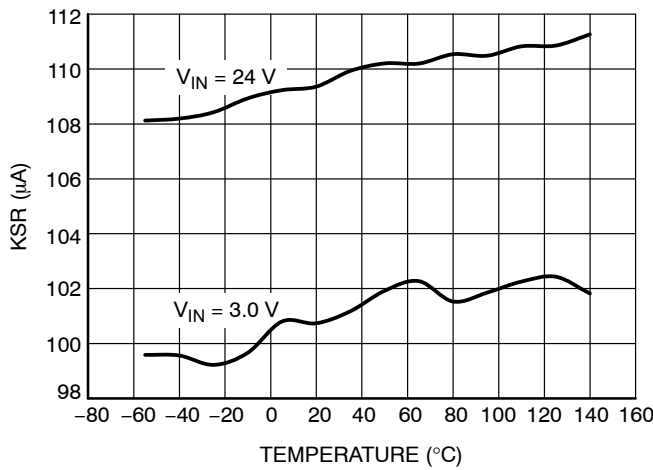


Figure 19. KSR vs. Temperature

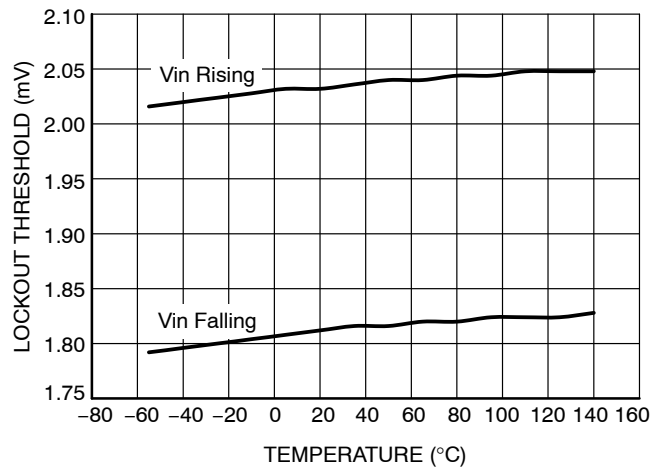


Figure 20. UVLO Trip Voltage vs. Temperature

TYPICAL CHARACTERISTICS

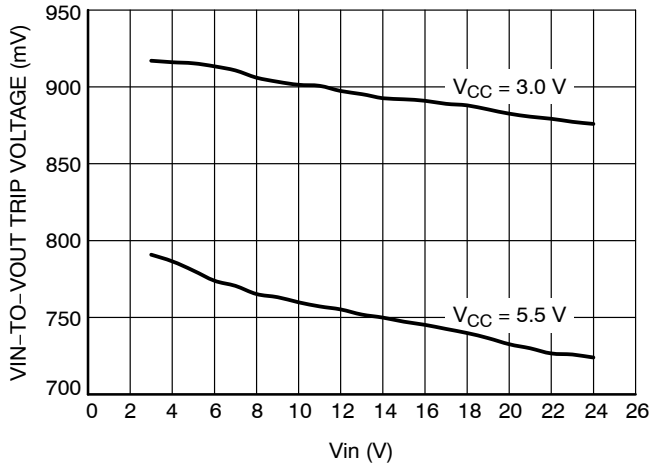


Figure 21. OCP Trip Voltage vs. Input Voltage (OCP = Open)

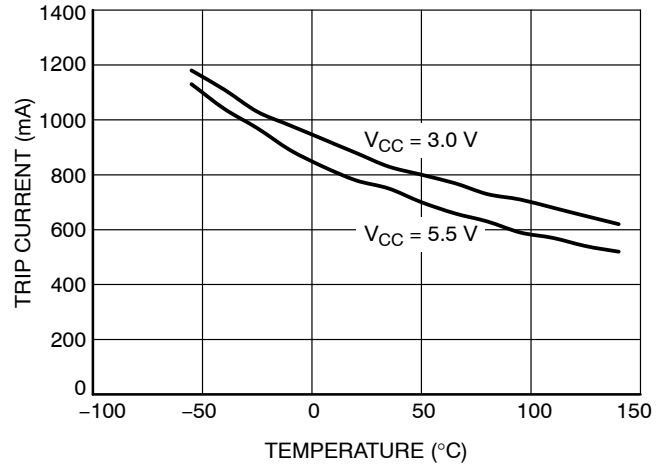


Figure 22. OCP Trip Current vs. Temperature (OCP = Open)

APPLICATIONS INFORMATION

Enable Control

The NCP45780 part enables the MOSFET in an active-high configuration. When the EN pin is at a logic high level and the V_{CC} supply pin has an adequate voltage applied, the MOSFET will be enabled. When the EN pin is at a logic low level, the MOSFET will be disabled. An internal pull down resistor to ground on the EN pin ensures that the MOSFET will be disabled when not driven.

Short-Circuit Protection (Hard short)

The NCP45780 device is equipped with short-circuit protection that helps protect the part and the system from a sudden high-current event, such as the output, V_{OUT} , being hard-short to ground.

Once active, the circuitry monitors the voltage difference between the V_{IN} pin and the V_{OUT} pin. When the difference is equal to the short-circuit protection threshold voltage, the MOSFET is turned off. The part remains off and is latched in the Fault state until EN is toggled or V_{CC} supply voltage is cycled, at which point the MOSFET will be turned on in a controlled fashion with the normal output turn-on delay and slew rate.

Over-Current Protection (Soft short)

The NCP45780 device is equipped with an over-current protection (OCP) that helps protect the part and the system from a high current event which exceeds the expected operational current (e.g., a soft short).

In the event that the current from the V_{IN} pin to the V_{OUT} pin exceeds the OCP threshold for longer than the blanking time, the MOSFET will shut down and the PG pin is driven low. Like the short-circuit protection, the part remains latched in the Fault state until EN is toggled or V_{CC} supply voltage is cycled, at which point the MOSFET will be turned on in a controlled fashion with the normal output turn-on delay and slew rate.

The over-current trip point is determined by the resistance between the OCP pin and ground. If no over-current protection is needed, then the OCP pin should be tied to GND; if the OCP protection is disabled in this way, the short-circuit protection will still remain active.

Thermal Shutdown

The thermal shutdown of the NCP45780 device protects the part from internally or externally generated excessive temperatures. When an over-temperature condition is detected, the MOSFET is turned off.

The part comes out of thermal shutdown when the junction temperature decreases to a safe operating temperature as dictated by the thermal hysteresis. Upon exiting a thermal shutdown state, and if EN remains active, the MOSFET will be turned on in a controlled fashion with the normal output turn-on delay and slew rate.

Under Voltage Lockout

The under voltage lockout of the NCP45780 device turns the MOSFET off when the input voltage, V_{IN} , drops below the under voltage lockout threshold.

If the V_{IN} voltage rises above the under voltage lockout threshold, and EN remains active, the MOSFET will be turned on in a controlled fashion with the normal output turn-on delay and slew rate.

Power Good

The NCP45780 device has a power good output (PG) that can be used to indicate when the gate of the MOSFET is fully charged. The PG pin is an active-high, open-drain output that requires an external pull up resistor, R_{PG} , greater than or equal to 100 k Ω to an external voltage source, V_{TERM} , that is compatible with input levels of all devices connected to this pin.

The power good output can be used as the enable signal for other active-high devices in the system. This allows for guaranteed by design power sequencing and reduces the number of enable signals needed from the system controller. If the power good feature is not used in the application, the PG pin should be tied to GND.

Slew Rate Control

The NCP45780 device is equipped with controlled output slew rate, which provides soft start functionality. This limits the inrush current caused by capacitor charging and enables these devices to be used in hot swapping applications.

The slew rate can be decreased with an external capacitor added between the SR pin and ground. With an external capacitor present, the slew rate can be determined by the following equation:

$$\text{Slew Rate} = \frac{K_{SR}}{C_{SR}} \text{ [V/s]} \quad (\text{eq. 1})$$

where K_{SR} is the specified slew rate control constant, found on page 3, and C_{SR} is the capacitor added between the SR pin and ground. Note that the slew rate of the device will always be the lower of the default slew rate and the adjusted slew rate. Therefore, if the C_{SR} is not large enough to decrease the slew rate more than the specified default value, the slew rate of the device will be the default value.

Capacitive Load

The peak in-rush current associated with the initial charging of the application load capacitance needs to stay below the specified I_{max} . C_L (capacitive load) should be less than C_{max} as defined by the following equation:

$$C_{max} = \frac{I_{max}}{SR_{typ}} \quad (\text{eq. 2})$$

where I_{max} is the maximum load current, and SR_{typ} is the typical default slew rate when no external load capacitor is added to the SR pin.

OFF to ON Transition Energy Dissipation

The energy dissipation due to load current traveling from V_{IN} to V_{OUT} is very low during steady state operation due to the low R_{ON} . When the EN signal is asserted high, the load switch transitions from an OFF state to an ON state. During this time, the resistance from V_{IN} to V_{OUT} transitions from high impedance to R_{ON} , and additional energy is dissipated in the device for a short period of time. The worst case energy dissipated during the OFF to ON transition can be approximated by the following equation:

$$E = 0.5 \cdot V_{IN} \cdot (I_{INRUSH} + 0.8 \cdot I_{LOAD}) \cdot dt \quad (\text{eq. 3})$$

where V_{IN} is the voltage on the V_{IN} pin, I_{INRUSH} is the inrush current caused by capacitive loading on V_{OUT} , and dt is the time it takes V_{OUT} to rise from 0 V to V_{IN} . I_{INRUSH} can be calculated using the following equation:

$$I_{INRUSH} = \frac{dv}{dt} \cdot C_L \quad (\text{eq. 4})$$

where dv/dt is the programmed slew rate, and C_L is the capacitive loading on V_{OUT} . To prevent thermal lockout or damage to the device, the energy dissipated during the OFF to ON transition should be limited to E_{TRANS} listed in operating ranges table.

ecoSwitch LAYOUT GUIDELINES**Electrical Layout Considerations**

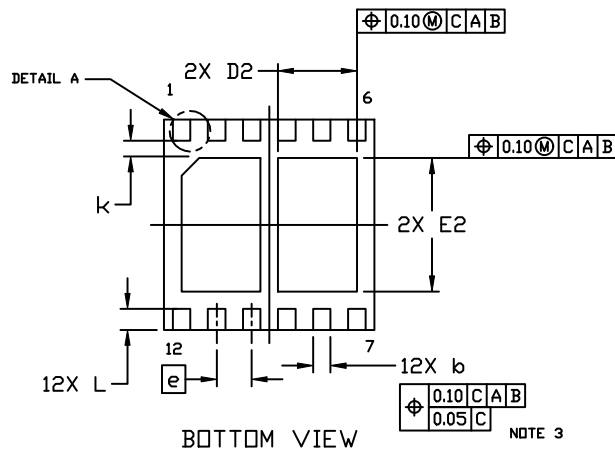
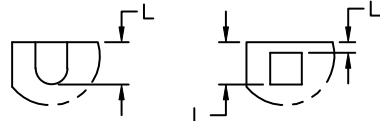
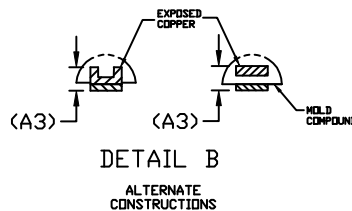
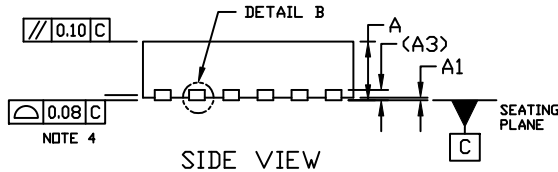
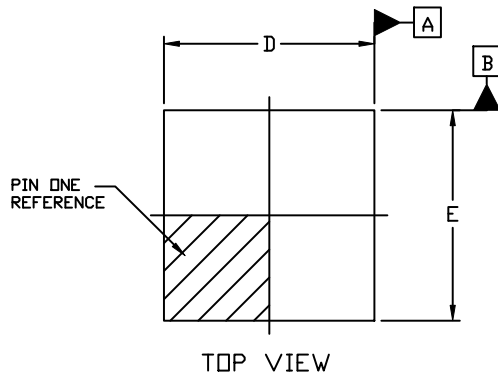
Correct physical PCB layout is important for proper low noise accurate operation of all ecoSwitch products.

Power Planes: The ecoSwitch is optimized for extremely low R_{ON} resistance, however, improper PCB layout can substantially increase source to load series resistance by adding PCB board parasitic resistance. Solid connections to the V_{IN} and V_{OUT} pins of the ecoSwitch to copper planes should be used to achieve low series resistance and good thermal dissipation. The ecoSwitch requires ample heat dissipation for correct thermal lockout operation. The internal FET dissipates load condition dependent amounts of power in the milliseconds following the rising edge of enable, and providing good thermal conduction from the packaging to the board is critical. The amount of heat spreading available to the part affects the maximum OCP threshold. Higher self-heating will cause the OCP trip point to decrease. Capacitive coupling of V_{IN} to V_{OUT} should be avoided, as this will adversely affect slew rates.

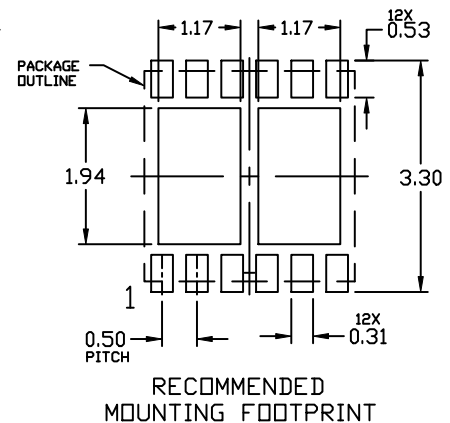


DFN12 3x3, 0.5P
CASE 506EN
ISSUE 0

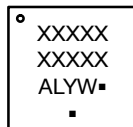
DATE 27 SEP 2018



DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.80	0.90	1.00
A1	0.00	—	0.05
A3	0.20 REF		
b	0.20	0.25	0.30
D	2.90	3.00	3.10
D2	1.03	1.13	1.23
E	2.90	3.00	3.10
E2	1.80	1.90	2.00
e	0.50 BSC		
k	0.20	—	—
L	0.20	0.30	0.40
L1	—	—	0.15



GENERIC
MARKING DIAGRAM*



XXXX = Specific Device Code
A = Assembly Location
L = Wafer Lot
Y = Year
W = Work Week
▪ = Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:	98AON98579G	Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.
DESCRIPTION:	DFN12 3x3, 0.5P	PAGE 1 OF 1

onsemi and onsemi are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

onsemi, **Onsemi**, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "**onsemi**" or its affiliates and/or subsidiaries in the United States and/or other countries. **onsemi** owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of **onsemi**'s product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. **onsemi** reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and **onsemi** makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

Technical Library: www.onsemi.com/design/resources/technical-documentation
onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at
www.onsemi.com/support/sales